Docket No.: 63979-031

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Customer Number: 20277

Tanaka HIDEYUKI, et al.

Confirmation Number: 1429

Serial No.: 10/646,816

Group Art Unit: 2812

Filed: August 25, 2003

Examiner:

For:

NON-VOLATILE MEMORY AND THE FABRICATION METHOD THEREOF

INFORMATION DISCLOSURE STATEMENT

Mail Stop IDS Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In a ccordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

Serial No.:

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

MCDERMOTT, WILL & EMERY

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Date: December 17, 2003

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INFORMATION DISCLOSURE CITATION IN AN APPLICATION DEC 1 7 2003					ATTY. DOCKET NO. 63979-031		SERIAL NO. 10/646,816		
					APPLICANT Tanaka HIDEYUKI	APPLICANT Tanaka HIDEYUKI, et al.			
(PTO-1449) U.S. PATENT					FILING DATE				
					August 25, 2003				
DEMA	<i>(</i>			U.S. PATE	NT DOCUMENTS				
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code2 (# known)		Publication Dat MM-DD-YYYY	Name of Patentee or Applicant of Cited Document		Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
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					or, Title, Date, Pertinent Pages, E				
EXAMINER'S INITIALS	CITE NO.	journ	de name of the author (in al, serial, symposium, cat shed.	CAPITAL LETTEF alog, etc.), date, p	RS), title of the article (when appro age(s), volume-issue number(s), p	opriate), title of oublisher, city a	the item (book, magazine ind/or country where	,	
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.